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Applications of "<u>Embedded - Microcontrollers</u>"

Details	
Product Status	Active
Core Processor	PIC
Core Size	8-Bit
Speed	40MHz
Connectivity	I ² C, SPI, UART/USART
Peripherals	Brown-out Detect/Reset, HLVD, POR, PWM, WDT
Number of I/O	54
Program Memory Size	48KB (24K x 16)
Program Memory Type	FLASH
EEPROM Size	1K x 8
RAM Size	3936 x 8
Voltage - Supply (Vcc/Vdd)	2V ~ 5.5V
Data Converters	A/D 12x10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	64-TQFP
Supplier Device Package	64-TQFP (10x10)
Purchase URL	https://www.e-xfl.com/product-detail/microchip-technology/pic18lf6527t-i-pt

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TABLE 1-3: PIC18F6527/6622/6627/6722 PINOUT I/O DESCRIPTIONS (CONTINUED)

Pin Name	Pin Number	Pin	Buffer	Description
Pin Name	TQFP	Туре	Туре	Description
				PORTF is a bidirectional I/O port.
RF0/AN5 RF0 AN5	18	I/O I	ST Analog	Digital I/O. Analog input 5.
RF1/AN6/C2OUT RF1 AN6 C2OUT	17	I/O I O	ST Analog —	Digital I/O. Analog input 6. Comparator 2 output.
RF2/AN7/C1OUT RF2 AN7 C1OUT	16	I/O I O	ST Analog —	Digital I/O. Analog input 7. Comparator 1 output.
RF3/AN8 RF3 AN8	15	I/O I	ST Analog	Digital I/O. Analog input 8.
RF4/AN9 RF4 AN9	14	I/O I	ST Analog	Digital I/O. Analog input 9.
RF5/AN10/CVREF RF5 AN10 CVREF	13	I/O I O	ST Analog Analog	Digital I/O. Analog input 10. Comparator reference voltage output.
RF6/AN11 RF6 AN11	12	I/O I	ST Analog	Digital I/O. Analog input 11.
RF7/SS1 RF7 SS1	11	I/O I	ST TTL	Digital I/O. SPI slave select input.

Legend: TTL = TTL compatible input CMOS = CMOS compatible input or output

ST = Schmitt Trigger input with CMOS levels Analog= Analog input I = Input O = Output

P = Power I^2C^{TM} = $I^2C/SMBus$ input buffer

Note 1: Default assignment for ECCP2 when Configuration bit, CCP2MX, is set.

2: Alternate assignment for ECCP2 when Configuration bit, CCP2MX, is cleared.

REGISTER 10-2: INTCON2: INTERRUPT CONTROL REGISTER 2

R/W-1	R/W-1	R/W-1	R/W-1	R/W-1	R/W-1	R/W-1	R/W-1
RBPU	INTEDG0	INTEDG1	INTEDG2	INTEDG3	TMR0IP	INT3IP	RBIP
bit 7	•						bit 0

Legend:

R = Readable bit W = Writable bit U = Unimplemented bit, read as '0'

-n = Value at POR '1' = Bit is set '0' = Bit is cleared x = Bit is unknown

bit 7 RBPU: PORTB Pull-up Enable bit

1 = All PORTB pull-ups are disabled

0 = PORTB pull-ups are enabled by individual port latch values

bit 6 INTEDG0: External Interrupt 0 Edge Select bit

1 = Interrupt on rising edge0 = Interrupt on falling edge

bit 5 INTEDG1: External Interrupt 1 Edge Select bit

1 = Interrupt on rising edge0 = Interrupt on falling edge

bit 4 INTEDG2: External Interrupt 2 Edge Select bit

1 = Interrupt on rising edge0 = Interrupt on falling edge

bit 3 INTEDG3: External Interrupt 3 Edge Select bit

1 = Interrupt on rising edge0 = Interrupt on falling edge

bit 2 TMR0IP: TMR0 Overflow Interrupt Priority bit

1 = High priority0 = Low priority

bit 1 INT3IP: INT3 External Interrupt Priority bit

1 = High priority0 = Low priority

bit 0 RBIP: RB Port Change Interrupt Priority bit

1 = High priority0 = Low priority

Note: Interrupt flag bits are set when an interrupt condition occurs, regardless of the state of its corresponding enable bit or the global interrupt enable bit. User software should ensure the appropriate interrupt flag bits

are clear prior to enabling an interrupt. This feature allows for software polling.

REGISTER 10-11: IPR2: PERIPHERAL INTERRUPT PRIORITY REGISTER 2

R/W-1	R/W-1	U-0	R/W-1	R/W-1	R/W-1	R/W-1	R/W-1
OSCFIP	CMIP	_	EEIP	BCL1IP	HLVDIP	TMR3IP	CCP2IP
bit 7							bit 0

Legend:

R = Readable bit W = Writable bit U = Unimplemented bit, read as '0'

-n = Value at POR '1' = Bit is set '0' = Bit is cleared x = Bit is unknown

bit 7 OSCFIP: Oscillator Fail Interrupt Priority bit

1 = High priority

0 = Low priority

bit 6 CMIP: Comparator Interrupt Priority bit

1 = High priority0 = Low priority

bit 5 **Unimplemented:** Read as '0'

bit 4 **EEIP:** Interrupt Priority bit

1 = High priority0 = Low priority

bit 3 BCL1IP: MSSP1 Bus Collision Interrupt Priority bit

1 = High priority0 = Low priority

bit 2 **HLVDIP:** High/Low-Voltage Detect Interrupt Priority bit

1 = High priority0 = Low priority

bit 1 TMR3IP: TMR3 Overflow Interrupt Priority bit

1 = High priority0 = Low priority

bit 0 CCP2IP: ECCP2 Interrupt Priority bit

1 = High priority0 = Low priority

TABLE 11-1: PORTA FUNCTIONS

Pin Name	Function	TRIS Setting	I/O	I/O Type	Description			
RA0/AN0	RA0	0	0	DIG	LATA<0> data output; not affected by analog input.			
		1	I	TTL	PORTA<0> data input; disabled when analog input enabled.			
	AN0	1	I	ANA	A/D input channel 0. Default input configuration on POR; does not affect digital output.			
RA1/AN1	RA1	0	0	DIG	LATA<1> data output; not affected by analog input.			
		1	I	TTL	PORTA<1> data input; disabled when analog input enabled.			
	AN1	1	I	ANA	A/D input channel 1. Default input configuration on POR; does not affect digital output.			
RA2/AN2/VREF-	RA2	0	0	DIG	LATA<2> data output; not affected by analog input.			
		1	I	TTL	PORTA<2> data input. Disabled when analog functions enabled.			
	AN2	1	I	ANA	A/D input channel 2. Default input configuration on POR.			
	VREF-	1	I	ANA	Comparator voltage reference low input and A/D voltage reference low input.			
RA3/AN3/VREF+	RA3	0	0	DIG	LATA<3> data output; not affected by analog input.			
		1	I	TTL	PORTA<3> data input; disabled when analog input enabled.			
	AN3	1	I	ANA	A A/D input channel 3. Default input configuration on POR.			
	VREF+	1	I	ANA	Comparator voltage reference high input and A/D voltage reference high input.			
RA4/T0CKI	RA4	0	0	DIG	LATA<4> data output.			
		1	I	ST	PORTA<4> data input; default configuration on POR.			
	T0CKI	х	I	ST	Timer0 clock input.			
RA5/AN4/HLVDIN	RA5	0	0	DIG	LATA<5> data output; not affected by analog input.			
		1	I	TTL	PORTA<5> data input; disabled when analog input enabled.			
	AN4	1	I	ANA	A/D input channel 4. Default configuration on POR.			
	HLVDIN	1	I	ANA	High/Low-Voltage Detect external trip point input.			
OSC2/CLKO/RA6	OSC2	х	0	ANA	Main oscillator feedback output connection (XT, HS, HSPLL and LP modes).			
	CLKO	х	0	DIG	System cycle clock output (Fosc/4) in all oscillator modes except RC, INTIO7 and EC.			
	RA6	0	0	DIG	LATA<6> data output. Enabled in RCIO, INTIO2 and ECIO modes only.			
		1	I	TTL	PORTA<6> data input. Enabled in RCIO, INTIO2 and ECIO modes only.			
OSC1/CLKI/RA7	OSC1	х	I	ANA	Main oscillator input connection.			
	CLKI	х	I	ANA	Main clock input connection.			
	RA7	0	0	DIG	LATA<7> data output. Disabled in external oscillator modes.			
		1	I	TTL	PORTA<7> data input. Disabled in external oscillator modes.			

Legend: PWR = Power Supply, O = Output, I = Input, ANA = Analog Signal, DIG = Digital Output, ST= Schmitt Buffer Input, TTL = TTL Buffer Input, x = Don't care (TRIS bit does not affect port direction or is overridden for this option).

TABLE 11-2: SUMMARY OF REGISTERS ASSOCIATED WITH PORTA

Name	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	Reset Values on page
PORTA	RA7 ⁽¹⁾	RA6 ⁽¹⁾	RA5	RA4	RA3	RA2	RA1	RA0	61
LATA	LATA7 ⁽¹⁾	LATA6 ⁽¹⁾	LATA5	LATA4	LATA3	LATA2	LATA1	LATA0	60
TRISA	TRISA7 ⁽¹⁾	TRISA6 ⁽¹⁾	TRISA5	TRISA4	TRISA3	TRISA2	TRISA1	TRISA0	60
ADCON1	_	_	VCFG1	VCFG0	PCFG3	PCFG2	PCFG1	PCFG0	59

Legend: — = unimplemented, read as '0'. Shaded cells are not used by PORTA.

Note 1: RA<7:6> and their associated latch and data direction bits are enabled as I/O pins based on oscillator configuration; otherwise, they are read as '0'.

TABLE 11-3: PORTB FUNCTIONS

Pin Name	Function	TRIS Setting	I/O	I/O Type	Description
RB0/INT0/FLT0	RB0	0	0	DIG	LATB<0> data output.
		1	ı	TTL	PORTB<0> data input; weak pull-up when RBPU bit is cleared.
	INT0	1	ı	ST	External interrupt 0 input.
	FLT0	1	ı	ST	ECCPx PWM Fault input, enabled in software.
RB1/INT1	RB1	0	0	DIG	LATB<1> data output.
		1	I	TTL	PORTB<1> data input; weak pull-up when RBPU bit is cleared.
	INT1	1	I	ST	External interrupt 1 input.
RB2/INT2	RB2	0	0	DIG	LATB<2> data output.
		1	I	TTL	PORTB<2> data input; weak pull-up when RBPU bit is cleared.
	INT2	1	I	ST	External interrupt 2 input.
RB3/INT3/	RB3	0	0	DIG	LATB<3> data output.
ECCP2/P2A		1	I	TTL	PORTB<3> data input; weak pull-up when RBPU bit is cleared and capture input is disabled.
	INT3	1	I	ST	External interrupt 3 input.
	ECCP2 ⁽¹⁾	0	0	DIG	ECCP2 compare output and ECCP2 PWM output. Takes priority over port data.
		1	I	ST	ECCP2 capture input.
	P2A ⁽¹⁾	0	0	DIG	ECCP2 Enhanced PWM output, channel A. May be configured for tri-state during Enhanced PWM shutdown events. Takes priority over port data.
RB4/KBI0	RB4	0	0	DIG	LATB<4> data output.
		1	I	TTL	PORTB<4> data input; weak pull-up when RBPU bit is cleared.
	KBI0	1	ı	TTL	Interrupt-on-pin change.
RB5/KBI1/PGM	RB5	0	0	DIG	LATB<5> data output
		1	I	TTL	PORTB<5> data input; weak pull-up when RBPU bit is cleared.
	KBI1	1	ı	TTL	Interrupt-on-pin change.
	PGM	х	I	ST	Single-Supply Programming mode entry (ICSP). Enabled by LVP Configuration bit; all other pin functions disabled.
RB6/KBI2/PGC	RB6	0	0	DIG	LATB<6> data output.
		1	I	TTL	PORTB<6> data input; weak pull-up when RBPU bit is cleared.
	KBI2	1	ı	TTL	Interrupt-on-pin change.
	PGC	х	I	ST	Serial execution (ICSP™) clock input for ICSP and ICD operation (2).
RB7/KBI3/PGD	RB7	0	0	DIG	LATB<7> data output.
		1	I	TTL	PORTB<7> data input; weak pull-up when RBPU bit is cleared.
	KBI3	1	I	TTL	Interrupt-on-pin change.
	PGD	х	0	DIG	Serial execution data output for ICSP and ICD operation ⁽²⁾ .
		х	I	ST	Serial execution data input for ICSP and ICD operation ⁽²⁾ .

Legend: PWR = Power Supply, O = Output, I = Input, ANA = Analog Signal, DIG = Digital Output, ST = Schmitt Buffer Input, TTL = TTL Buffer Input, x = Don't care (TRIS bit does not affect port direction or is overridden for this option).

2: All other pin functions are disabled when ICSP or ICD operations are enabled.

Note 1: Alternate assignment for ECCP2 when the CCP2MX Configuration bit is cleared (Microprocessor, Extended Microcontroller and Microcontroller with Boot Block modes, 80-pin devices only). Default assignment is RC1.

12.0 TIMERO MODULE

The Timer0 module incorporates the following features:

- Software selectable operation as a timer or counter in both 8-bit or 16-bit modes
- · Readable and writable registers
- Dedicated 8-bit, software programmable prescaler
- · Selectable clock source (internal or external)
- · Edge select for external clock
- · Interrupt-on-overflow

The TOCON register (Register 12-1) controls all aspects of the module's operation, including the prescale selection. It is both readable and writable.

A simplified block diagram of the Timer0 module in 8-bit mode is shown in Figure 12-1. Figure 12-2 shows a simplified block diagram of the Timer0 module in 16-bit mode.

REGISTER 12-1: TOCON: TIMERO CONTROL REGISTER

R/W-1	R/W-1	R/W-1	R/W-1	R/W-1	R/W-1	R/W-1	R/W-1
TMR0ON	T08BIT	T0CS	T0SE	PSA	T0PS2	T0PS1	T0PS0
bit 7							bit 0

Legend:			
R = Readable bit	W = Writable bit	U = Unimplemented bit	, read as '0'
-n = Value at POR	'1' = Bit is set	'0' = Bit is cleared	x = Bit is unknown

bit 7	TMR0ON: Timer0 On/Off Contro	l bit

1 = Enables Timer00 = Stops Timer0

bit 6 T08BIT: Timer0 8-bit/16-bit Control bit

1 = Timer0 is configured as an 8-bit timer/counter 0 = Timer0 is configured as a 16-bit timer/counter

bit 5 Tocs: Timer0 Clock Source Select bit

1 = Transition on T0CKI pin

0 = Internal instruction cycle clock (CLKO)

bit 4 T0SE: Timer0 Source Edge Select bit

1 = Increment on high-to-low transition on T0CKI pin 0 = Increment on low-to-high transition on T0CKI pin

bit 3 PSA: Timer0 Prescaler Assignment bit

1 = TImer0 prescaler is NOT assigned. Timer0 clock input bypasses prescaler.

0 = Timer0 prescaler is assigned. Timer0 clock input comes from prescaler output.

bit 2-0 T0PS<2:0>: Timer0 Prescaler Select bits

111 = 1:256 Prescale value

110 = 1:128 Prescale value

101 = 1:64 Prescale value

100 = 1:32 Prescale value

011 = 1:16 Prescale value

010 = 1:8 Prescale value

001 = 1:4 Prescale value

000 = 1:2 Prescale value

NOTES:

19.4.17.2 Bus Collision During a Repeated Start Condition

During a Repeated Start condition, a bus collision occurs if:

- A low level is sampled on SDAx when SCLx goes from low level to high level.
- SCLx goes low before SDAx is asserted low, indicating that another master is attempting to transmit a data '1'.

When the user deasserts SDAx and the pin is allowed to float high, the BRG is loaded with SSPxADD<6:0> and counts down to '0'. The SCLx pin is then deasserted and when sampled high, the SDAx pin is sampled.

If SDAx is low, a bus collision has occurred (i.e., another master is attempting to transmit a data '0', Figure 19-29). If SDAx is sampled high, the BRG is reloaded and begins counting. If SDAx goes from high-to-low before the BRG times out, no bus collision occurs because no two masters can assert SDAx at exactly the same time.

If SCLx goes from high-to-low before the BRG times out and SDAx has not already been asserted, a bus collision occurs. In this case, another master is attempting to transmit a data '1' during the Repeated Start condition (see Figure 19-30).

If, at the end of the BRG time-out, both SCLx and SDAx are still high, the SDAx pin is driven low and the BRG is reloaded and begins counting. At the end of the count, regardless of the status of the SCLx pin, the SCLx pin is driven low and the Repeated Start condition is complete.

FIGURE 19-29: BUS COLLISION DURING A REPEATED START CONDITION (CASE 1)

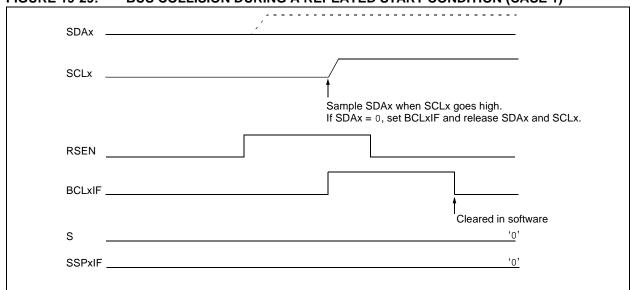
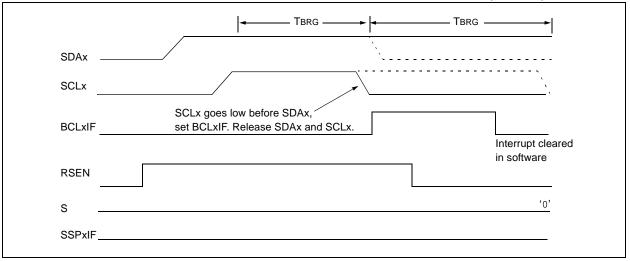


FIGURE 19-30: BUS COLLISION DURING REPEATED START CONDITION (CASE 2)



REGISTER 20-2: RCSTAX: RECEIVE STATUS AND CONTROL REGISTER

R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R-0	R-0	R-x
SPEN	RX9	SREN	CREN	ADDEN	FERR	OERR	RX9D
bit 7							bit 0

Legend:

R = Readable bit W = Writable bit U = Unimplemented bit, read as '0'

-n = Value at POR '1' = Bit is set '0' = Bit is cleared x = Bit is unknown

bit 7 SPEN: Serial Port Enable bit

1 = Serial port enabled (configures RXx/DTx and TXx/CKx pins as serial port pins)

0 = Serial port disabled (held in Reset)

bit 6 **RX9:** 9-bit Receive Enable bit

1 = Selects 9-bit reception0 = Selects 8-bit reception

bit 5 SREN: Single Receive Enable bit

Asynchronous mode:

Don't care.

Synchronous mode - Master:

1 = Enables single receive

0 = Disables single receive

This bit is cleared after reception is complete.

Synchronous mode – Slave:

Don't care.

bit 4 CREN: Continuous Receive Enable bit

Asynchronous mode:

1 = Enables receiver

0 = Disables receiver

Synchronous mode:

1 = Enables continuous receive until enable bit CREN is cleared (CREN overrides SREN)

0 = Disables continuous receive

bit 3 ADDEN: Address Detect Enable bit

Asynchronous mode 9-bit (RX9 = 1):

1 = Enables address detection, enables interrupt and loads the receive buffer when RSRx<8> is set

0 = Disables address detection, all bytes are received and ninth bit can be used as parity bit

Asynchronous mode 9-bit (RX9 = 0):

Don't care.

bit 2 **FERR:** Framing Error bit

1 = Framing error (can be updated by reading RCREGx register and receiving next valid byte)

0 = No framing error

bit 1 OERR: Overrun Error bit

1 = Overrun error (can be cleared by clearing bit CREN)

0 = No overrun error

bit 0 **RX9D:** 9th bit of Received Data

This can be address/data bit or a parity bit and must be calculated by user firmware.

21.1 A/D Acquisition Requirements

For the A/D converter to meet its specified accuracy, the charge holding capacitor (Chold) must be allowed to fully charge to the input channel voltage level. The analog input model is shown in Figure 21-3. The source impedance (Rs) and the internal sampling switch (Rss) impedance directly affect the time required to charge the capacitor Chold. The sampling switch (Rss) impedance varies over the device voltage (VDD). The source impedance affects the offset voltage at the analog input (due to pin leakage current). The maximum recommended impedance for analog sources is 2.5 k Ω . After the analog input channel is selected (changed), the channel must be sampled for at least the minimum acquisition time before starting a conversion.

Note:

When the conversion is started, the holding capacitor is disconnected from the input pin.

To calculate the minimum acquisition time, Equation 21-1 may be used. This equation assumes that 1/2 LSb error is used (1024 steps for the A/D). The 1/2 LSb error is the maximum error allowed for the A/D to meet its specified resolution.

Example 21-3 shows the calculation of the minimum required acquisition time TACQ. This calculation is based on the following application system assumptions:

CHOLD = 25 pF Rs = $2.5 \text{ k}\Omega$ Conversion Error \leq 1/2 LSb

VDD = $5V \rightarrow Rss = 2 \text{ k}\Omega$ Temperature = 85°C (system max.)

EQUATION 21-1: ACQUISITION TIME

```
TACQ = Amplifier Settling Time + Holding Capacitor Charging Time + Temperature Coefficient
= TAMP + TC + TCOFF
```

EQUATION 21-2: A/D MINIMUM CHARGING TIME

```
\begin{array}{lll} V_{HOLD} & = & (V_{REF} - (V_{REF}/2048)) \bullet (1 - e^{(-T_{C}/C_{HOLD}(R_{IC} + R_{SS} + R_{S}))}) \\ \text{or} \\ T_{C} & = & -(C_{HOLD})(R_{IC} + R_{SS} + R_{S}) \ln(1/2048) \end{array}
```

EQUATION 21-3: CALCULATING THE MINIMUM REQUIRED ACQUISITION TIME

```
 TACQ = TAMP + TC + TCOFF  TAMP = 0.2 μs  TCOFF = (Temp - 25^{\circ}C)(0.02 \text{ μs/°C})  (85°C - 25°C)(0.02 μs/°C) 1.2 μs  Temperature coefficient is only required for temperatures > 25°C. Below 25°C, TCOFF = 0 ms.  TC  = -(CHOLD)(RIC + Rss + Rs) \ln(1/2047) \text{ μs}  -(25 pF) (1 kΩ + 2 kΩ + 2.5 kΩ) \ln(0.0004883) \text{ μs}  1.05 μs  TACQ = 0.2 \text{ μs} + 1 \text{ μs} + 1.2 \text{ μs}  2.4 μs
```

24.0 HIGH/LOW-VOLTAGE DETECT (HLVD)

The PIC18F8722 family of devices have a High/Low-Voltage Detect module (HLVD). This is a programmable circuit that allows the user to specify both a device voltage trip point and the direction of change from that point. If the device experiences an excursion past the trip point in that direction, an interrupt flag is set. If the interrupt is enabled, the program execution will branch to the interrupt vector address and the software can then respond to the interrupt.

Legend:

R = Readable bit

High/Low-Voltage Detect Control register The (Register 24-1) completely controls the operation of the HLVD module. This allows the circuitry to be "turned off" by the user under software control, which minimizes the current consumption for the device.

The block diagram for the HLVD module is shown in Figure 24-1.

REGISTER 24-1: HLVDCON: HIGH/LOW-VOLTAGE DETECT CONTROL REGISTER

W = Writable bit

R/W-0	U-0	R-0	R/W-0	R/W-0	R/W-1	R/W-0	R/W-1
VDIRMAG	_	IRVST	HLVDEN	HLVDL3 ⁽¹⁾	HLVDL2 ⁽¹⁾	HLVDL1 ⁽¹⁾	HLVDL0 ⁽¹⁾
bit 7							bit 0

U = Unimplemented bit, read as '0'

-n = Value at	POR	'1' = Bit is set	'0' = Bit is cleared	x = Bit is unknown				
bit 7	VDIRMAG	3: Voltage Direction Magn	itude Select bit					
	1 = Event occurs when voltage equals or exceeds trip point (HLVDL<3:0>) 0 = Event occurs when voltage equals or falls below trip point (HLVDL<3:0>)							
bit 6	Unimplen	nented: Read as '0'						
bit 5	IRVST: Int	ternal Reference Voltage	Stable Flag bit					
	 1 = Indicates that the voltage detect logic will generate the interrupt flag at the specified voltage range 0 = Indicates that the voltage detect logic will not generate the interrupt flag at the specified voltage range and the HLVD interrupt should not be enabled 							
bit 4	HLVDEN: 1 = HLVD 0 = HLVD		Power Enable bit					
bit 3-0	HLVDL<3	:0>: Voltage Detection Lir	mit bits ⁽¹⁾					
		kternal analog input is use aximum setting	ed (input comes from the HLVDIN	l pin)				
	· ·							

Note 1: See Table 28-4 for specifications.

0000 = Minimum setting

MOVLW Move Literal to W Syntax: MOVLW k Operands: $0 \le k \le 255$ Operation: $\mathsf{k}\to\mathsf{W}$ Status Affected: None Encoding: 0000 1110 kkkk kkkk Description: The eight-bit literal 'k' is loaded into W. Words: Cycles:

Q Cycle Activity:

Q1	Q2	Q3	Q4
Decode	Read	Process	Write to
	literal 'k'	Data	W

Example: MOVLW 5Ah

After Instruction

W = 5Ah

MOVWF	Move W to f					
Syntax:	MOVWF	f {,a}				
Operands:	$0 \le f \le 255$ a $\in [0,1]$					
Operation:	$(W) \to f$					
Status Affected:	None					
Encoding:	0110	111a	ffff	ffff		
Description:	Move data from W to register 'f'. Location 'f' can be anywhere in the 256-byte bank.					

If 'a' is '1', the BSR is used to select the GPR bank (default). If 'a' is '0' and the extended instruction set is enabled, this instruction operates in Indexed Literal Offset Addressing mode whenever $f \le 95$ (5Fh). See

If 'a' is '0', the Access Bank is selected.

Section 26.2.3 "Byte-Oriented and Bit-Oriented Instructions in Indexed Literal Offset Mode" for details.

Words: 1 Cycles: 1

Q Cycle Activity:

Q1	Q2	Q3	Q4
Decode	Read	Process	Write
	register 'f'	Data	register 'f'

Example: MOVWF REG, 0

Before Instruction

W = 4Fh REG = FFh

After Instruction

W = 4FhREG = 4Fh 28.2 DC Characteristics: Power-Down and Supply Current

PIC18F6X27/6X22/8X27/8X22 (Industrial, Extended) PIC18LF6X27/6X22/8X27/8X22 (Industrial) (Continued)

(Industrial)		Standard Operating Conditions (unless otherwise stated) Operating temperature $-40^{\circ}\text{C} \le \text{TA} \le +85^{\circ}\text{C}$ for industrial						
		Standard Operating Conditions (unless otherwise stated) Operating temperature $-40^{\circ}\text{C} \le \text{TA} \le +85^{\circ}\text{C}$ for industrial $-40^{\circ}\text{C} \le \text{TA} \le +125^{\circ}\text{C}$ for extended						
Param No.	Device	Тур	Max	Units		Conditi	ons	
	Supply Current (IDD) ⁽²⁾							
	PIC18LF6X27/6X22/8X27/8X22	1.0	1.3	mA	-40°C			
		1.0	1.3	mA	+25°C	VDD = 2.0V		
		1.0	1.3	mA	+85°C			
	PIC18LF6X27/6X22/8X27/8X22	1.6	1.9	mA	-40°C			
		1.6	1.9	mA	+25°C	VDD = 3.0V	FOSC = 4 MHz (RC_RUN mode,	
		1.6	1.9	mA	+85°C		Internal oscillator source)	
	All devices	3.0	3.5	mA	-40°C		,	
		3.0	3.4	mA	+25°C	VDD = 5.0V		
		3.0	3.4	mA	+85°C	VDD = 3.0V		
	Extended devices only	3.0	3.4	mA	+125°C			
	PIC18LF6X27/6X22/8X27/8X22	3.5	5	μΑ	-40°C			
		3.7	5	μΑ	+25°C	VDD = 2.0V		
		4.3	9.5	μΑ	+85°C			
	PIC18LF6X27/6X22/8X27/8X22	5.4	7	μΑ	-40°C			
		5.7	8	μΑ	+25°C	VDD = 3.0V	FOSC = 31 kHz (RC IDLE mode,	
		7.0	15	μΑ	+85°C		Internal oscillator source)	
	All devices	11	15	μΑ	-40°C			
		11.8	15	μΑ	+25°C	VDD = 5.0V	\/DD - F 0\/	
		13.5	35	μΑ	+85°C	VDD = 5.0V		
	Extended devices only	25	200	μΑ	+125°C			

Legend: Shading of rows is to assist in readability of the table.

- Note 1: The power-down current in Sleep mode does not depend on the oscillator type. Power-down current is measured with the part in Sleep mode, with all I/O pins in high-impedance state and tied to VDD or Vss and all features that add delta current disabled (such as WDT, Timer1 Oscillator, BOR, etc.).
 - 2: The supply current is mainly a function of operating voltage, frequency and mode. Other factors, such as I/O pin loading and switching rate, oscillator type and circuit, internal code execution pattern and temperature, also have an impact on the current consumption.

The test conditions for all IDD measurements in active operation mode are:

 $\frac{\text{OSC1}}{\text{MCLR}}$ = external square wave, from rail-to-rail, all I/O pins tri-stated, pulled to VDD OR VSS; $\frac{\text{MCLR}}{\text{MCLR}}$ = VDD; WDT enabled/disabled as specified.

- 3: When operation below -10°C is expected, use T1OSC High-Power mode, where LPT1OSC (CONFIG3H<2>) = 0. When operation will always be above -10°C, then the low-power Timer1 oscillator may be selected.
- **4:** BOR and HLVD enable internal band gap reference. With both modules enabled, current consumption will be less than the sum of both specifications.

TABLE 28-1: MEMORY PROGRAMMING REQUIREMENTS

			Standard Operating Conditions (unless otherwise stated) Operating temperature -40°C ≤ TA ≤ +85°C for industrial				
Param No.	Sym	Characteristic	Min	Тур†	Max	Units	Conditions
		Data EEPROM Memory					
D120	ED	Byte Endurance	100K	1M	_	E/W	-40°C to +85°C
D121	VDRW	VDD for Read/Write	VMIN	_	5.5	V	Using EECON to read/write VMIN = Minimum operating voltage
D122	TDEW	Erase/Write Cycle Time	_	4	_	ms	
D123	TRETD	Characteristic Retention	40	_	_	Year	Provided no other specifications are violated
D124	TREF	Number of Total Erase/Write Cycles before Refresh ⁽¹⁾	1M	10M	_	E/W	-40°C to +85°C
D125	IDDP	Supply Current during Programming	_	10	_	mA	
		Program Flash Memory					
D130	EР	Cell Endurance	10K	100K	_	E/W	-40°C to +85°C
D131	VPR	VDD for Read	VMIN	_	5.5	V	VMIN = Minimum operating voltage
D132B	VPEW	VDD for Self-Timed Write and Row Erase	VMIN	_	5.5	V	VMIN = Minimum operating voltage
D133A	Tıw	Self-Timed Write Cycle Time	_	2	_	ms	
D134	TRETD	Characteristic Retention	40	100	_	Year	Provided no other specifications are violated
D135	IDDP	Supply Current during Programming	_	10	_	mA	

[†] Data in "Typ" column is at 5.0V, 25°C unless otherwise stated. These parameters are for design guidance only and are not tested.

Note 1: Refer to Section 8.8 "Using the Data EEPROM" for a more detailed discussion on data EEPROM endurance.

TABLE 28-2: COMPARATOR SPECIFICATIONS

Operating Conditions: 3.0V < VDD < 5.5V, -40°C < TA < +85°C (unless otherwise stated)							
Param No.	Sym	Characteristics	Min	Тур	Max	Units	Comments
D300	VIOFF	Input Offset Voltage	_	±5.0	±10	mV	
D301	VICM	Input Common Mode Voltage	0	_	VDD - 1.5	V	
D302	CMRR	Common Mode Rejection Ratio	55	_	_	dB	
300	TRESP	Response Time ⁽¹⁾	_	150	400	ns	PIC18FXXXX
300A			_	150	600	ns	PIC18 LF XXXX, VDD = 2.0V
301	TMC2OV	Comparator Mode Change to Output Valid	_	_	10	μS	

Note 1: Response time measured with one comparator input at (VDD – 1.5)/2, while the other input transitions from Vss to VDD.

TABLE 28-3: COMPARATOR VOLTAGE REFERENCE SPECIFICATIONS

Operating	Operating Conditions: 3.0V < VDD < 5.5V, -40°C < TA < +85°C (unless otherwise stated)						
Param No.	Sym	Characteristics	Min	Тур	Max	Units	Comments
D310	VRES	Resolution	VDD/24	_	VDD/32	LSb	
D311	VRAA	Absolute Accuracy	_	_	1/2	LSb	
D312	VRur	Unit Resistor Value (R)	_	2k	_	Ω	
310	TSET	Settling Time ⁽¹⁾	_	_	10	μS	

Note 1: Settling time measured while CVRR = 1 and CVR<3:0> transitions from '0000' to '1111'.

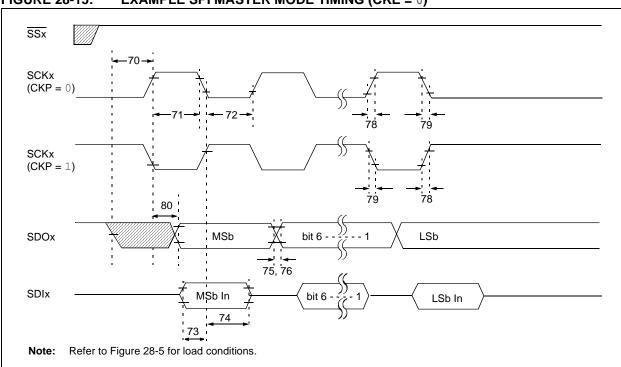


FIGURE 28-15: EXAMPLE SPI MASTER MODE TIMING (CKE = 0)

TABLE 28-16: EXAMPLE SPI MODE REQUIREMENTS (MASTER MODE, CKE = 0)

Param No.	Symbol	Characteristi	c	Min	Max	Units	Conditions
70	TssL2scH, TssL2scL	SSx ↓ to SCKx ↓ or SCKx ↑ In	put	Tcy	_	ns	
71	TscH	SCKx Input High Time	Continuous	1.25 Tcy + 30	_	ns	
71A		(Slave mode)	Single Byte	40	_	ns	(Note 1)
72	TscL	SCKx Input Low Time	Continuous	1.25 Tcy + 30	_	ns	
72A		(Slave mode)	Single Byte	40	_	ns	(Note 1)
73	TDIV2SCH, TDIV2SCL	Setup Time of SDIx Data Input	20	_	ns		
73A	Тв2в	Last Clock Edge of Byte 1 to the 1st Clock Edge of Byte 2		1.5 Tcy + 40	_	ns	(Note 2)
74	TscH2DIL, TscL2DIL	Hold Time of SDIx Data Input t	o SCKx Edge	40	_	ns	
75	TDOR	SDOx Data Output Rise Time	PIC18FXXXX	_	25	ns	
			PIC18 LF XXXX	_	45	ns	VDD = 2.0V
76	TDOF	SDOx Data Output Fall Time		_	25	ns	
78	TscR	SCKx Output Rise Time	PIC18FXXXX	_	25	ns	
		(Master mode)	Master mode) PIC18LFXXXX		45	ns	VDD = 2.0V
79	TscF	SCKx Output Fall Time (Maste	SCKx Output Fall Time (Master mode)		25	ns	
80	TscH2DoV,	SDOx Data Output Valid after	PIC18FXXXX	_	50	ns	
	TscL2doV	SCKx Edge	PIC18 LF XXXX		100	ns	VDD = 2.0V

Note 1: Requires the use of Parameter #73A.

2: Only if Parameter #71A and #72A are used.

FIGURE 28-18: EXAMPLE SPI SLAVE MODE TIMING (CKE = 1)

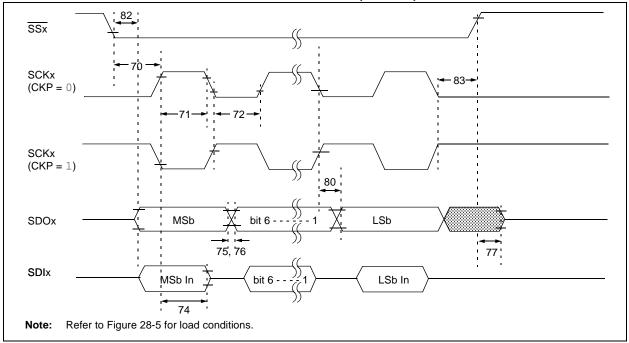


TABLE 28-19: EXAMPLE SPI SLAVE MODE REQUIREMENTS (CKE = 1)

Param No.	Symbol	Characteristic		Min	Max	Units	Conditions
70	TssL2scH, TssL2scL	SSx ↓ to SCKx ↓ or SCKx ↑ Input		3 Tcy	_	ns	
71	TscH	SCKx Input High Time	Continuous	1.25 Tcy + 30	_	ns	
71A		(Slave mode)	Single Byte	40	_	ns	(Note 1)
72	TscL	SCKx Input Low Time	Continuous	1.25 Tcy + 30	_	ns	
72A		(Slave mode)	Single Byte	40	_	ns	(Note 1)
73A	Тв2в	Last Clock Edge of Byte 1 to the First Cl	ock Edge of Byte 2	1.5 Tcy + 40	_	ns	(Note 2)
74	TscH2DIL, TscL2DIL	Hold Time of SDIx Data Input to SCKx	40	_	ns		
75	TDOR	SDOx Data Output Rise Time	PIC18FXXXX	_	25	ns	
			PIC18 LF XXXX	_	45	ns	VDD = 2.0V
76	TDOF	SDOx Data Output Fall Time		1	25	ns	
77	TssH2DoZ	SSx ↑ to SDOx Output High-Impedan	ce	10	50	ns	
78	TscR	SCKx Output Rise Time	PIC18FXXXX	_	25	ns	
		(Master mode)	PIC18 LF XXXX	_	45	ns	VDD = 2.0V
79	TscF	SCKx Output Fall Time (Master mode))	_	25	ns	
80		SDOx Data Output Valid after SCKx	PIC18FXXXX	_	50	ns	
	TscL2doV	Edge	PIC18 LF XXXX	_	100	ns	VDD = 2.0V
82	TssL2DoV	SDOx Data Output Valid after SSx ↓	PIC18FXXXX	_	50	ns	
		Edge	PIC18 LF XXXX	_	100	ns	VDD = 2.0V
83	TscH2ssH, TscL2ssH	SSx ↑ after SCKx Edge		1.5 Tcy + 40	_	ns	

Note 1: Requires the use of Parameter #73A.

2: Only if Parameter #71A and #72A are used.

NOTES:

PIC18F8722 FAMILY PRODUCT IDENTIFICATION SYSTEM

To order or obtain information, e.g., on pricing or delivery, refer to the factory or the listed sales office.

PART N Device	— T — T	Examples: a) PIC18LF6622-I/PT 301 = Industrial temp., TQFP package, Extended VDD limits, QTP pattern #301.			
Device	PIC18F6527/6622/6627/6722 ⁽¹⁾ , PIC18F8527/8622/8627/8722 ⁽¹⁾ , PIC18F6527/6622/6627/6722T ⁽²⁾ , PIC18F8527/8622/8627/8722T ⁽²⁾ ; VDD range 4.2V to 5.5V PIC18LF6627/6722 ⁽¹⁾ , PIC18LF8627/8722T ⁽²⁾ , PIC18LF6627/6722T ⁽²⁾ , PIC18LF8627/8722T ⁽²⁾ ; VDD range 2.0V to 5.5V	b) PIC18LF6722-E/PT = Extended temp., TQFP package, standard VDD limits.			
Temperature Range	I = -40°C to +85°C (Industrial) E = -40°C to +125°C (Extended)				
Package Pattern	PT = TQFP (Thin Quad Flatpack) QTP, SQTP, Code or Special Requirements (blank otherwise)	Note 1: F = Standard Voltage Range LF = Wide Voltage Range 2: T = in tape and reel TQFP packages only.			